

Phase-out/Discontinued

**N-CHANNEL POWER MOS FET ARRAY
SWITCHING TYPE**

DESCRIPTION

The μ PA1570 is N-channel Power MOS FET Array that built in 4 circuits designed for solenoid, motor and lamp driver.

FEATURES

- 4 V driving is possible
- Large Current and Low On-state Resistance
 $I_{D(pulse)} = \pm 8$ A
 $R_{DS(on)} \leq 0.35 \Omega$ MAX. ($V_{GS} = 10$ V)
 $R_{DS(on)} \leq 0.50 \Omega$ MAX. ($V_{GS} = 4$ V)
- 2.54 mm Pitch (0.1 inch)

ORDERING INFORMATION

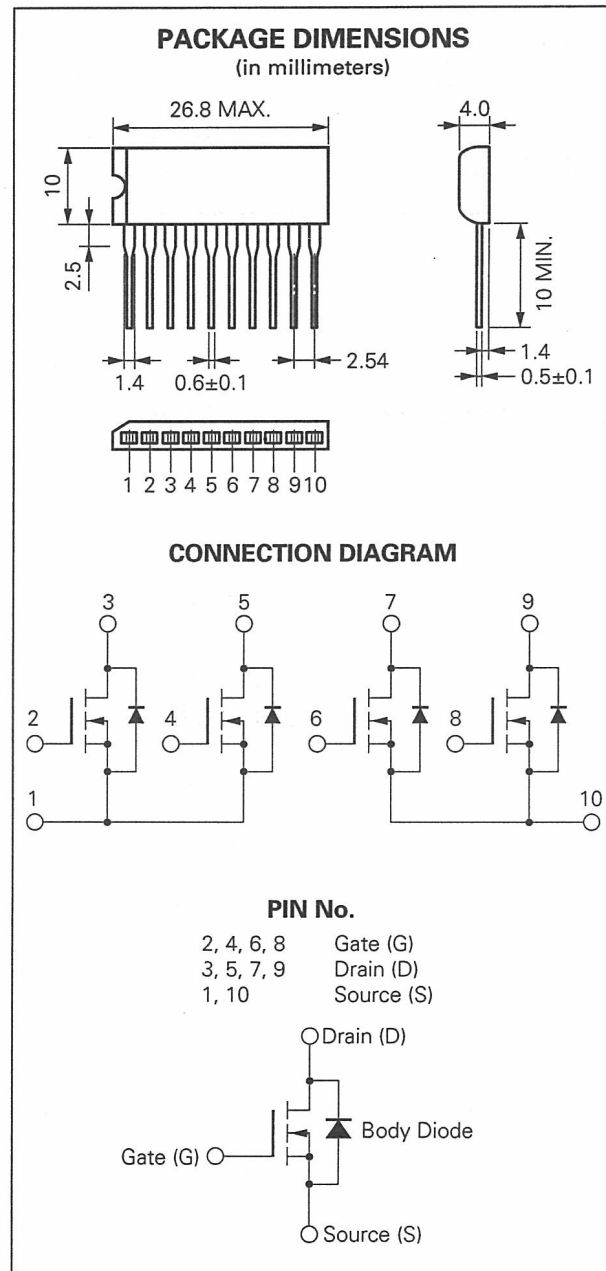
| Part Number | Package | Quality Grade |
|---------------|------------|---------------|
| μ PA1570H | 10 pin SIP | Standard |

Please refer to "Quality grade on NEC Semiconductor Devices" (Document number IEI-1209) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

| | | | |
|--------------------------------------|---|-------------|------------------|
| Drain to Source Voltage | V_{DSS} | 30 | V |
| Gate to Source Voltage | V_{GSS} | ± 20 | V |
| Drain Current (DC) | $I_{D(DC)}$ | ± 2.0 | A/unit |
| Drain Current (pulse) | $I_{D(pulse)*}$ | ± 8.0 | A/unit |
| Total Power Dissipation (4 circuits) | | | |
| | $\langle T_c = 25^\circ\text{C} \rangle P_{T1}$ | 28 | W |
| Total Power Dissipation (4 circuits) | | | |
| | $\langle T_a = 25^\circ\text{C} \rangle P_{T2}$ | 3.5 | W |
| Storage Temperature | T_{stg} | -55 to +150 | $^\circ\text{C}$ |
| Junction Temperature | T_j | 150 | $^\circ\text{C}$ |

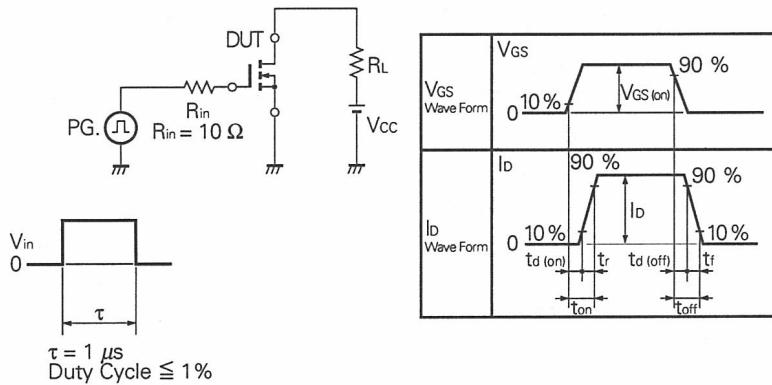
* $PW \leq 300 \mu\text{s}$, Duty Cycle $\leq 10\%$



ELECTRICAL CHARACTERISTICS (T_a = 25 °C)

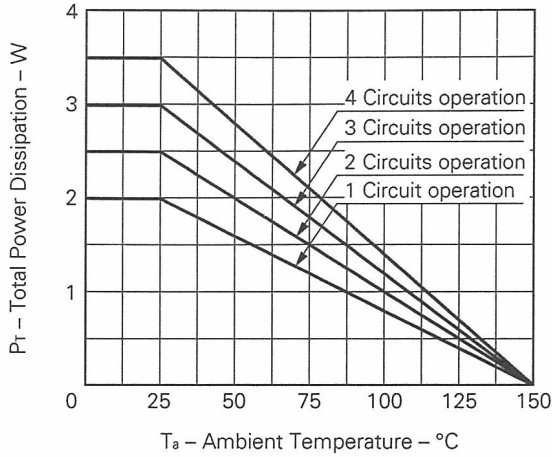
| CHARACTERISTIC | SYMBOL | MIN. | TYP. | MAX. | UNIT | TEST CONDITIONS |
|-------------------------------------|----------------------|------|------|------|------|---|
| Drain Leakage Current | I _{DSS} | | | 10 | μA | V _{DS} = 30 V, V _{GS} = 0 |
| Gate to Source Leakage Current | I _{GSS} | | | ±100 | nA | V _{GS} = ±20 V, V _{DS} = 0 |
| Gate to Source Cutoff Voltage | V _{GS(off)} | 1.0 | | 2.5 | V | V _{DS} = 10 V, I _D = 1 mA |
| Forward Transfer Admittance | y _{fs} | 1.0 | 1.6 | | S | V _{DS} = 10 V, I _D = 1 A |
| Drain to Source On-state Resistance | R _{DS(on)1} | | 0.2 | 0.35 | Ω | V _{GS} = 10 V, I _D = 1 A |
| Drain to Source On-state Resistance | R _{DS(on)2} | | 0.35 | 0.50 | Ω | V _{GS} = 4 V, I _D = 1.0 A |
| Input Capacitance | C _{iss} | | 270 | | pF | V _{DS} = 10 V V _{GS} = 0 f = 1.0 MHz |
| Output Capacitance | C _{oss} | | 150 | | pF | |
| Reverse Transfer Capacitance | C _{rss} | | 40 | | pF | |
| Turn-On Delay Time | t _{d(on)} | | 30 | | ns | I _D = 1 A V _{GS} = 10 V V _{CC} = 15 V R _L = 15 Ω, R _{in} = 10 Ω See Fig. 1 |
| Rise Time | t _r | | 90 | | ns | |
| Turn-Off Delay Time | t _{d(off)} | | 400 | | ns | |
| Fall Time | t _f | | 250 | | ns | |

Fig. 1 Switching Time Test Circuit

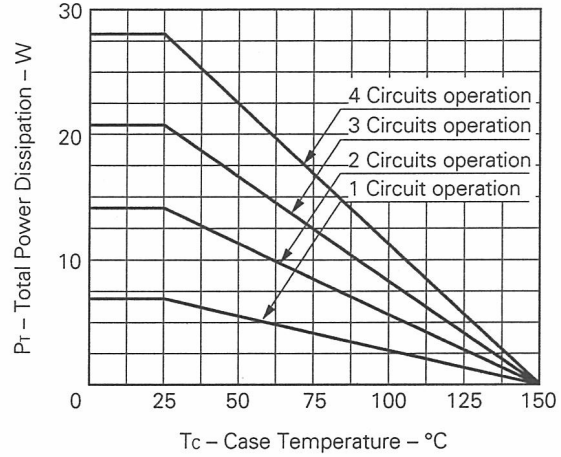


TYPICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

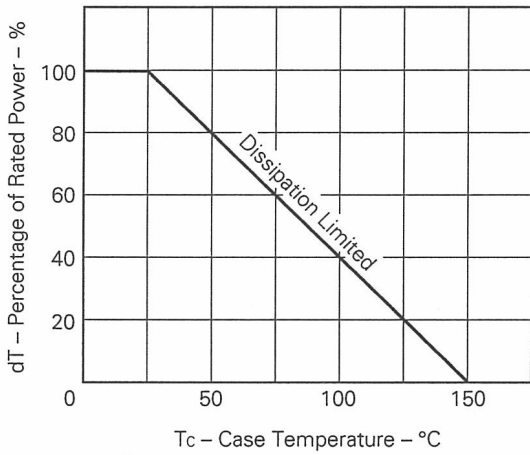
TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE



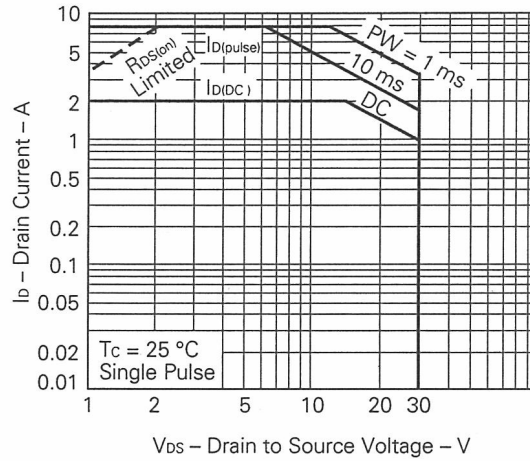
TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



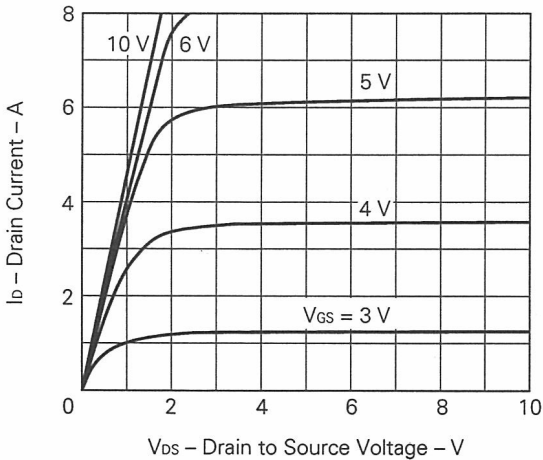
DERATING CURVE OF SAFE OPERATING AREA



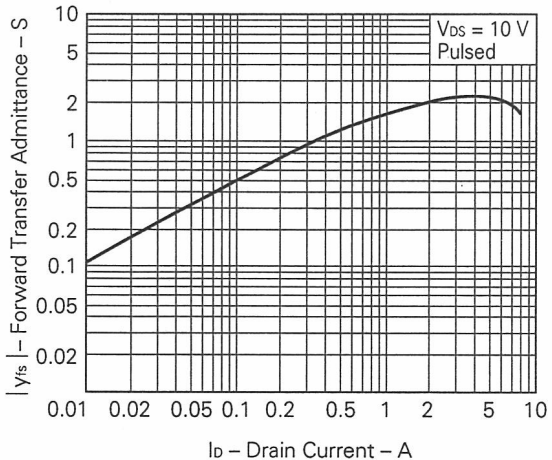
FORWARD BIAS SAFE OPERATING AREA



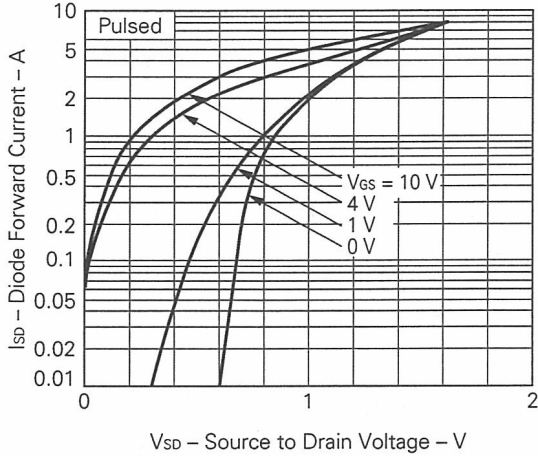
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



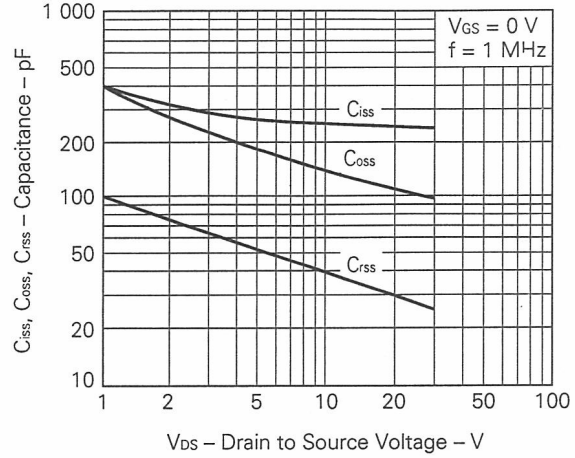
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



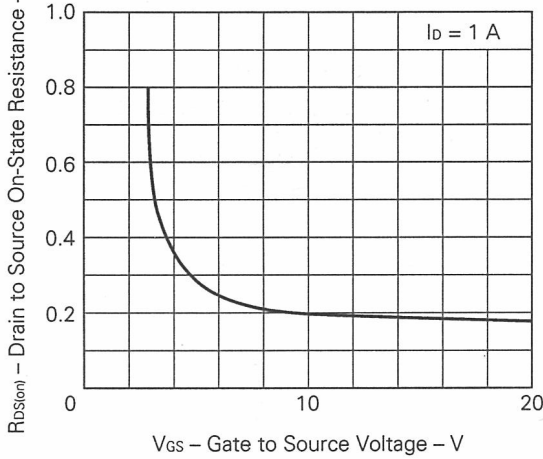
SOURCE TO DRAIN DIODE FORWARD VOLTAGE



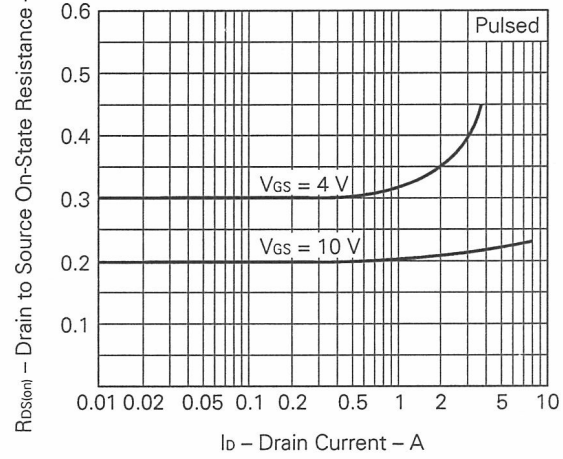
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



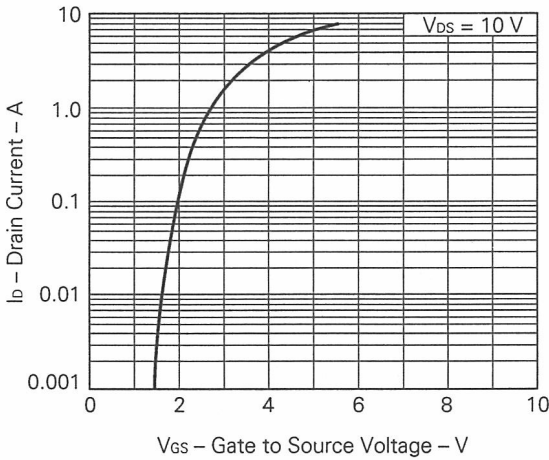
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



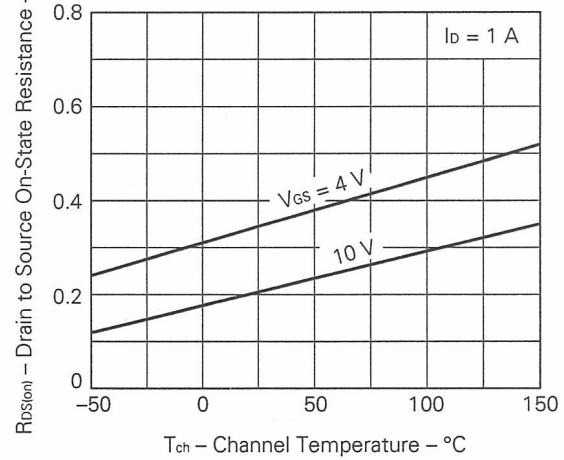
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



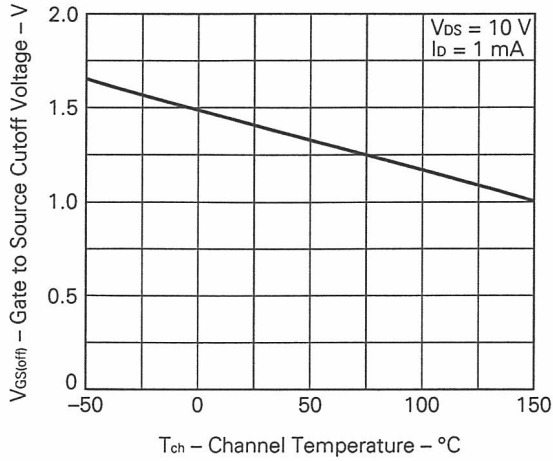
TRANSFER CHARACTERISTICS



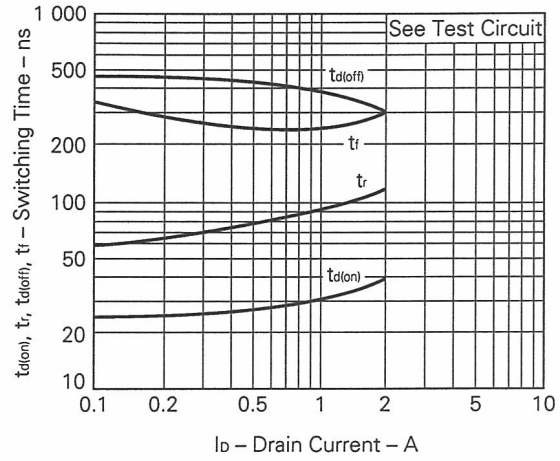
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



GATE TO SOURCE CUTOFF VOLTAGE vs. CHANNEL TEMPERATURE



SWITCHING TIME vs. DRAIN CURRENT



Reference

| Document name | Document No. |
|--|--------------|
| Quality control of NEC semiconductors devices. | TEI-1202 |
| Quality control guide of semiconductors devices. | MEI-1202 |
| Assembly manual of semiconductors devices. | IEI-1207 |
| Safe operating area of Power MOS FET | TEA-1034 |
| Appication circuit using Power MOS FET | TEA-1035 |

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